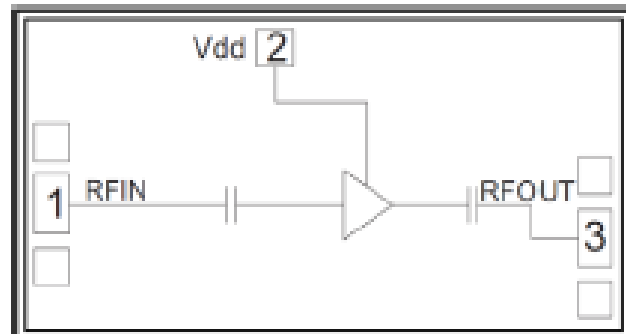


**Features**

- Single Biasing Voltage (Self Biased)
- Frequency: 5-20GHz
- Small Signal Gain: 22dB
- Gain Flatness:  $\leq \pm 2.0$ dB
- Noise Figure: 4.6dB typ.
- P1dB: 20dBm
- Psat: 20.5dBm
- Power Supply: +5V/125mA
- Input/Output: 50Ω
- Die Size: 1.85 x 1.05 x 0.1 mm

**Typical Applications**

- Test Instrumentation
- Microwave Radio & VSAT
- Military & Space
- Telecom Infrastructure
- Fiber Optics

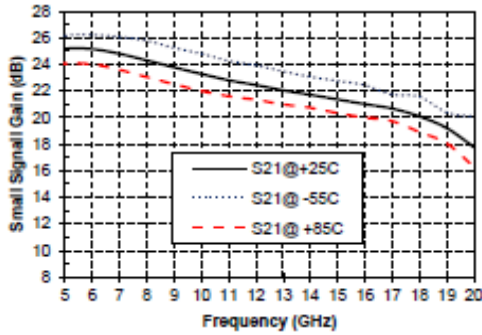
**Functional Block Diagram**

**Electrical Specifications**

TA = +25°C, Vd = +5V

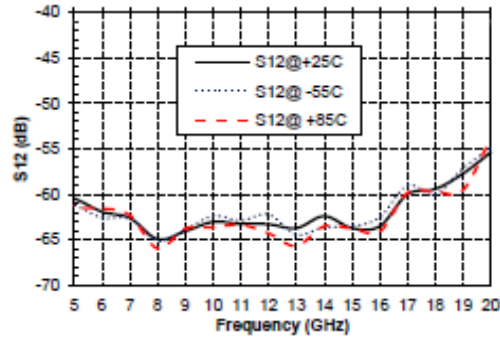
Parameters	Min.	Typ.	Max.	Units
Frequency		5-20		GHz
Small Signal Gain	17	22	25.5	dB
Gain Flatness		$\pm 2.0$		dB
Noise Figure		4.6		dB
Output 1dB Compression (P1dB)		20		dBm
Saturated Output Power (Psat)		20.5		dBm
Input Return Loss		20		dB
Output Return Loss		18		dB
Static Current	105	120	135	mA



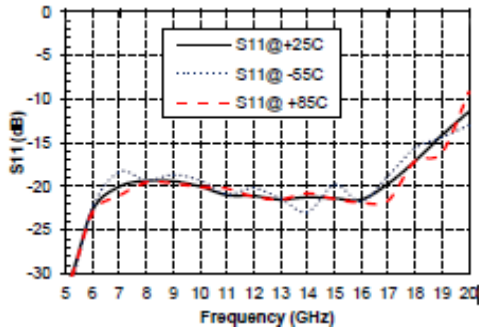
### Gain vs. Frequency



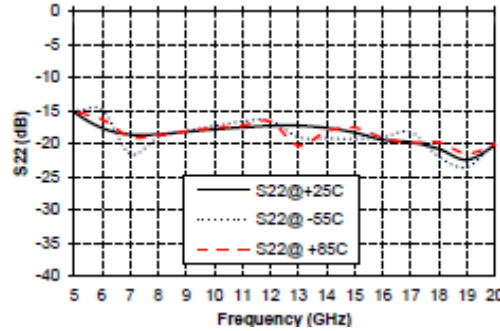
### Reverse Isolation vs. Frequency



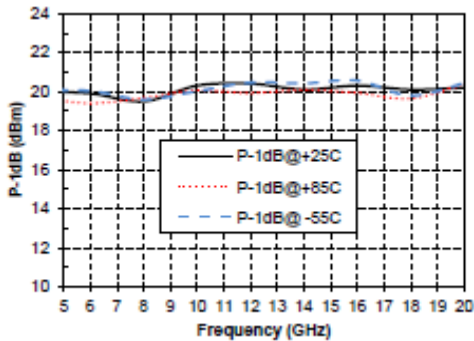
### Input Return Loss vs. Frequency



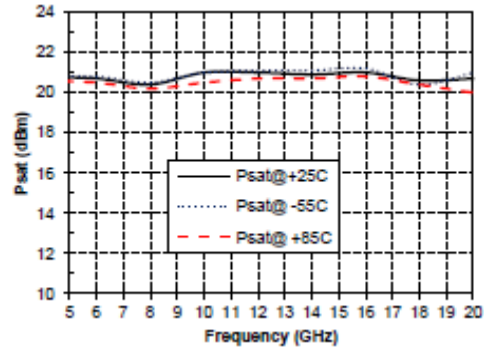
### Output Return Loss vs. Frequency



### P1dB vs. Frequency



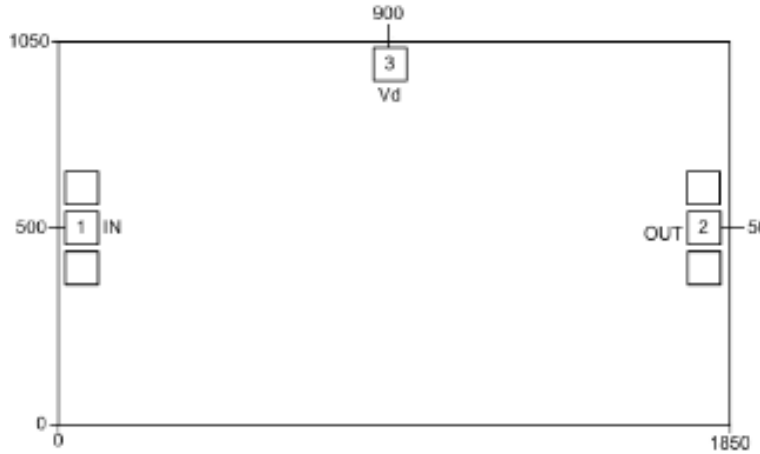
### Psat vs. Frequency





### Outline Drawing:

All Dimensions in  $\mu\text{m}$

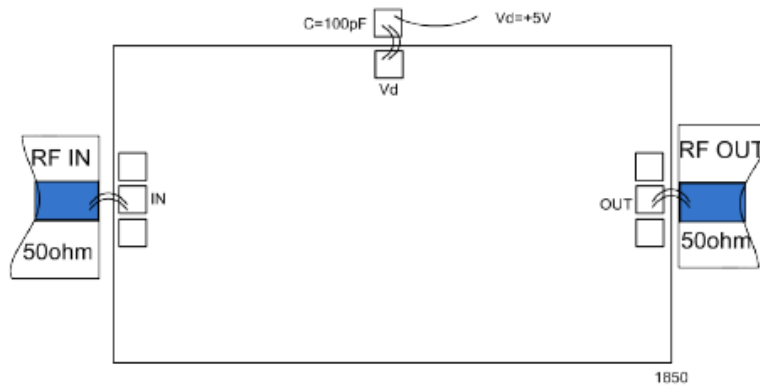


### Pad Description

Pad	Function	Description	Equivalent Circuit
1	RF IN	RF signal input terminal; no blocking capacitor required.	
2	RF OUT	RF signal output terminal; no blocking capacitor required.	
3	Vd	Amplifier drain bias; external 100pF bypass capacitor required.	
Die bottom	GND	Die bottom must be connected to RF/DC ground.	



### Assembly Drawing



#### Notes:

1. Die thickness: 100um
2. Typical bond pad is 100\*100  $\mu\text{m}^2$
3. Bond pad metalization: Gold
4. Backside metalization: Gold
5. Backside of the die (GND)
6. No connection required for unlabeled bond pads

#### Maximum Ratings:

1. Maximum drain voltage: +7V
2. Maximum input power: +20dBm
3. Operating temperature: -55°C to +85°C
4. Storage temperature: -65°C to +150°C